



Ref. Certif. No.

JPTUV-128596

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

CB TEST CERTIFICATE

Product

Charger IC

Name and address of the applicant

Texas Instruments Inc.  
12500 TI Boulevard  
Dallas TX 75243, USA

Name and address of the manufacturer

Texas Instruments Inc.  
12500 TI Boulevard  
Dallas TX 75243, USA

Name and address of the factory

Texas Instruments Inc.  
12500 TI Boulevard  
Dallas TX 75243, USA

Ratings and principal characteristics

Rated input: 24Vdc Max.  
Class III

Trademark (if any)

TEXAS INSTRUMENTS

Customer's Testing Facility (CTF) Stage used

N/A

Model / Type Ref.

BQ25790, BQ25792, BQ25798, BQ25672

Additional information (if necessary may also be reported on page 2)

For model differences, refer to test report

A sample of the product was tested and found to be in conformity with

IEC 62368-1:2018  
See Test Report for National Differences

As shown in the Test Report Ref. No. which forms part of this Certificate

CN21HIKE 001

This CB Test Certificate is issued by the National Certification Body



TÜVRheinland®

TÜV Rheinland Japan Ltd.  
Global Technology Assessment Center  
4-25-2 Kita-Yamata, Tsuzuki-ku  
Yokohama 224-0021, Japan  
Phone + 81 45 914-3888  
Fax + 81 45 914-3354  
Mail: info@jpn.tuv.com  
Web : www.tuv.com

Date: 2021-10-26

Signature:

Paddy Qiu